

KH206

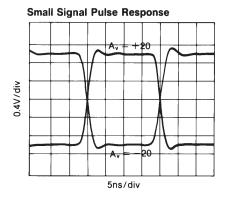
Overdrive-Protected Wideband Op Amp

Features

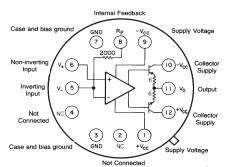
- -3dB bandwidth of 180MHz
- 70MHz large signal bandwidth (20V_{pp})
- 0.1% settling in 19ns
- Overdrive protected
- Output may be current limited
- Stable without compensation
- 3MΩ input impedance
- Direct replacement for CLC206

Applications

- Fast, precision A/D conversion
- Automatic test equipment
- Input/output amplifiers
- Photodiode, CCD preamps
- High-speed modems, radios
- Line drivers



Bottom View



Pin 8 provides access to a 2000Ω feedback resistor which can be connected to the output or left open if an external feedback resistor is desired.

General Description

The KH206 is a wideband, overdrive-protected operational amplifier designed for applications needing both speed and high drive capability (100mA). Utilizing a well-established current feedback architecture, the KH206 exhibits performance far beyond that of conventional voltage feedback op amps. For example, the KH206 has a bandwidth of 180MHz at a gain of +20 and settles to 0.1% in 19ns. Plus, the KH206 has a combination of important features not found in other high-speed op amps.

The 100mA output current and the large signal bandwidth of 70MHz (20V_{pp}) make the KH206 ideal for applications which involve both high signal amplitudes and heavy loads as in coaxial line driving applications.

Complete overdrive protection has been designed into the KH206. This is critical for applications, such as ATE and instrumentation, which require protection from signal levels high enough to cause saturation of the amplifier. This feature allows the output of the op amp to be protected against short circuits using techniques developed for low-speed op amps. With this capability, even the fastest signal sources can feature effective short circuit protection.

The KH206 is constructed using thin film resistor/bipolar transistor technology, and is available in the following versions:

KH206AI	-25°C to +85°C	12-pin TO-8 can
KH206AK	-55°C to +125°C	12-pin TO-8 can, features burn-in & hermetic testing
KH206AM	-55°C to +125°C	12-pin TO-8 can, environmentally screened and electrically tested to MIL-STD-883
KH206HXC	-55°C to +125°C	SMD#: 5962-8985801HXC
KH206HXA	-55°C to +125°C	SMD#: 5962-8985801HXA

Typical Performance

	gain setting						
parameter	+7	+20	+50	-1	-20	-50	units
-3dB bandwidth	220	180	90	220	145	90	MHz
rise time	1.6	2	4	1.6	2.5	4	ns
slew rate	3.4	3.4	3.4	3.4	3.4	3.4	V/ns
settling time (to 0.1%)	22	19	17	20	19	18	ns

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KH206 Electrical Characteristics ($A_v = +20$, $V_{cc} = \pm 15$ V, $R_L = 200\Omega$, $R_f = 2k\Omega$; unless specified)

PARAMETERS	CONDITIONS	TYP	TYP MAX & MIN RATINGS			UNITS	SYMBOL
Ambient Temperature	KH206AI	+25°C	−25°C	+25°C	+85°C		
Ambient Temperature	KH206AK/AM/HXC/HXA	+25°C	−55°C	+25°C	+125°C		
FREQUENCY DOMAIN RESPON +-3dB bandwidth large signal bandwidth gain flatness	$\begin{array}{l} \text{SE} \\ \text{V}_{\text{out}} < 2\text{V}_{\text{pp}} \\ \text{V}_{\text{out}} < 20\text{V}_{\text{pp}} \\ \text{V}_{\text{out}} < 2\text{V}_{\text{pp}} \end{array}$	180 70	>150 >54	>150 >60	>135 >60	MHz MHz	SSBW FPBW
peakingpeakingrolloffgroup delaylinear phase deviation	0.1 to 40MHz >40MHz at 75MHz to 75MHz to 75MHz	0 0 3.0±.2 0.6	<0.3 <0.5 <0.7 — <2.0	<0.3 <0.5 <0.7 — <1.5	<0.5 <0.8 <0.7 — <2.0	dB dB dB ns	GFPL GFPH GFR GD LPD
TIME DOMAIN RESPONSE rise and fall time settling time to 0.1% to 0.05% overshoot slew rate	2V step 20V step 10V step, note 2 10V step, note 2 10V step 20V _{pp} , 100MHz	2.0 7.0 22 24 11 3.4	<2.5 <8.5 <25 <27 <15 >2.7	<2.5 <8.5 <25 <27 <15 >3.0	<2.7 <8.5 <25 <27 <15 >3.0	ns ns ns ns % V/ns	TRS TRL TS TSP OS SR
DISTORTION AND NOISE RESP †2nd harmonic distortion †3rd harmonic distortion equivalent input noise voltage inverting current non-inverting current noise floor integrated noise noise floor integrated noise	ONSE 2V _{pp} , 20MHz 2V _{pp} , 20MHz >100kHz >100kHz >100kHz >100kHz >100kHz >500kHz 16Hz to 150MHz 55MHz 5MHz to 150MHz	-59 -67 2.1 22 5.0 -157 39 -157	<-50 <-55 <3.0 <30 <7.0 <-154 <55 <-154	<-50 <-55 <3.0 <30 <7.0 <-154 <55 <-154 <55	<-50 <-55 <3.5 <35 <8.0 <-153 <61 <-153 <61	dBc dBc nV/√Hz pA/√Hz pA/√Hz dBm(1Hz) uV dBm(1Hz) uV	HD2 HD3 VN ICN NCN SNF INV SNF
STATIC, DC PERFORMANCE *input offset voltage average temperature coeffi *input bias current average temperature coeffi *input bias current average temperature coeffi *power supply rejection ratio common mode rejection ratio *supply current	cient non-inverting cient inverting	3.5 11 4.0 20 2.0 40 65 60 29	<8.0 <25 <30 <125 <26 <200 >55 >50 <31	<8.0 <25 <20 <125 <10 <200 >55 >50 <31	<11.0 <25 <20 <125 <30 <200 >55 >50 <33	mV uV/°C uA nA/°C uA nA/°C dB dB mA	VIO DVIO IBN DIBN IBI DIBI PSRR CMRR ICC
MISCELLANEOUS PERFORMAN non-inverting input resistance non-inverting input capacitance output impedance output voltage range internal feedback resistor absolute tolerance	NCE DC 75MHz DC no load	3.0 5.2 — ±12	>1.0 <7.0 <0.1 >±11	>1.0 <7.0 <0.1 >±11 <0.2	>1.0 <7.0 <0.1 >±11	MΩ pF Ω V	RIN CIN RO VO
temperature coefficient inverting input current self limit		3.3	- <4.5	-100±40 <4.5	- <4.7	ppm/°C mA	RFTC ICL

Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

Absolute Maximum Ratings

 $\begin{array}{ccc} V_{cc} & \pm 20V \\ I_{out} & \pm 150 \text{mA} \\ \text{common mode input voltage} & \pm (|V_{cc}|-1)V \\ \text{differential input voltage} & \pm 3V \\ \text{thermal resistance: See thermal model.} \\ \text{junction temperature} & +175^{\circ}\text{C} \\ \text{operating temperature} & AI: -25^{\circ}\text{C to} +85^{\circ}\text{C} \\ & AK/AM/HXC/HXA: --55^{\circ}\text{C to} +125^{\circ}\text{C}, \\ \text{storage temperature} & -65^{\circ}\text{C to} +150^{\circ}\text{C} \\ \text{lead temperature (soldering 10s)} & +300^{\circ}\text{C} \\ \end{array}$

Recommended Operating Conditions

 $\begin{array}{lll} V_{cc} & \pm 5V \text{ to } \pm 15V \\ I_{out} & \pm 100\text{mA} \\ \text{common mode input voltage} & \pm (\mid V_{cc} \mid -5)V \\ \text{gain range:} & +7 \text{ to } +50, -1 \text{ to } -50 \end{array}$

note 1: * Al/AK/AM/HXC/HXA 100% tested at 25°C.

† AK/AM/HXC/HXA 100% tested at +25°C & sample tested

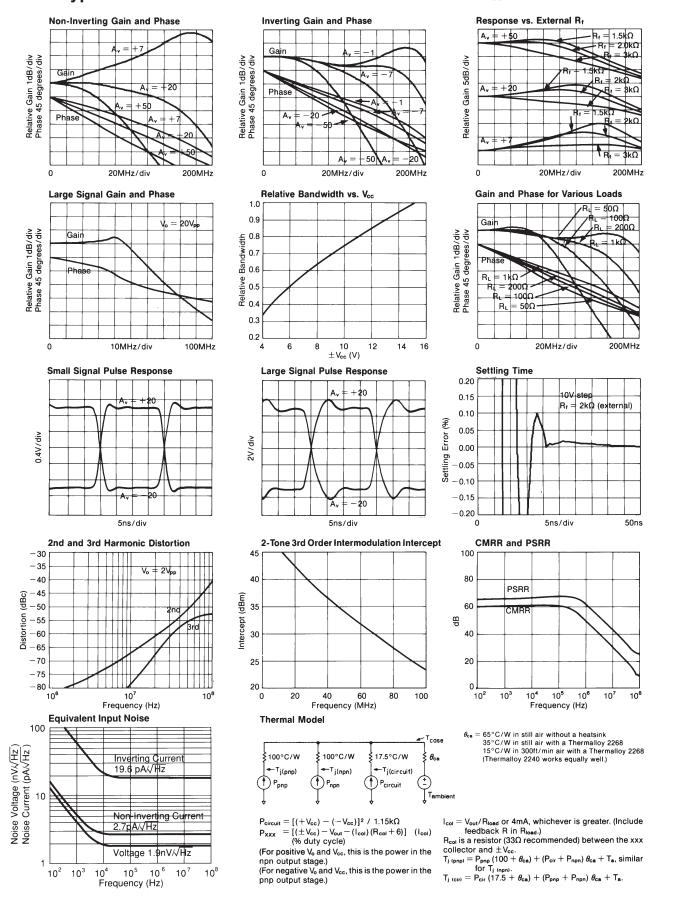
at-55°C & +125°C.

† Al sample tested at +25°C.

note 2: Settling time specifications require the use of an external feedback resistor (2Ω) .

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KH206 Typical Performance Characteristics (T_A = +25°C, A_V = +20, V_{CC} = ±15V, R_L = 200Ω; unless specified)



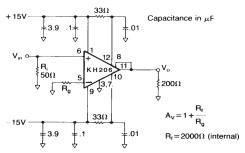


Figure 1: recommended non-inverting gain circuit

Overdrive Protection

Unlike most other high-speed op amps, the KH206 is not damaged by saturation caused by overdriving input signals (where $V_{\rm in}X$ gain> $V_{\rm out}$). The KH206 self limits the current at the inverting input when the output is saturated (see the inverting input current self limit specification); this ensures that the amplifier will not be damaged due to excessive internal currents during overdrive. For protection against input signals which would exceed either the maximum differential or common mode input voltage, the diode clamp circuits below may be used.

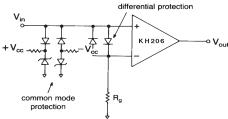


Figure 3: Diode clamp circuits for common mode and differential mode protection

Short Circuit Protection:

Damage caused by short circuits at the output may be prevented by limiting the output current to safe levels. The most simple current limit circuit calls for placing resistors between the output stage collector supplies and the output stage collectors (pins 12 and 10). The value of this resistor is determined by:

$$R_c = \frac{V_c}{I_1} - R_I$$

Where I_I is the desired limit current and R_I is the minimum expected load resistance (0 Ω for a short to ground). Bypass capacitors of 0.01 μ F on should be used on the collectors as in Figures 1 and 2.

A more sophisticated current limit circuit which provides a limit current independent of $\mathbf{R}_{\mathbf{l}}$ is shown below.

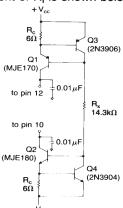


Figure 4: Active current limit circuit (100mA)

With the component values indicated, current limiting occurs at 100mA. For other values of current limit (I₁), select R_c to equal V_{be}/I_L Where V_{be} is the base to emitter voltage drop of Q3 (or Q4) at a current of $[2V_{cc}-1.4]/R_x$ where

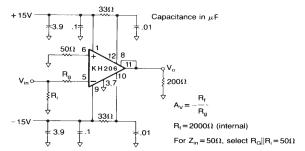


Figure 2: recommended inverting gain circuit

 $R_x \le [(2V_{cc} - 1.4)/I_l] B_{min.}$ Also, B_{min} is the minimum beta of Q1 (or Q2) at a current of I_l . Since the limit current depends on V_{be} , which is temperature dependent, the limit current is likewise temperature dependent.

Controlling Bandwidth and Passband Response

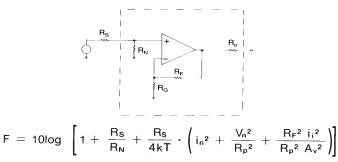
In most applications, a feedback resistor value of $2k\Omega$ will provide optimum performance; nonetheless, some applications may require a resistor of some other value. The response versus R_{f} plot on the previous page shows how decreasing R_{f} will increase bandwidth (and frequency response peaking, which may lead to instability). Conversely, large values of feedback resistance tend to roll off the response.

The best settling time performance requires the use of an external feedback resistor (use of the internal resistor results in a 0.1% to 0.2% settling tail). The settling performance may be improved slightly by adding a capacitance of 0.4pF in parallel with the feedback resistor (settling time specifications reflect performance with an external feedback resistor but with no external capacitance).

Noise Analysis

Approximate noise figure can be determined for the KH206 using the equivalent input noise graph on the preceding page and the equations shown below.

Noise figure is for the network inside this box



where
$$R_p=\frac{R_S~R_N}{R_S+R_N}$$
 ; $A_v=\frac{R_F}{R_G}+1$
$$kT=4.00\times 10^{-21}~Joules~at~290^\circ K$$

 V_n is spot noise voltage (V/\sqrt{Hz})

 i_n is non-inverting spot noise current (A/ \sqrt{Hz})

i_i is inverting spot noise current (A/\sqrt{Hz})

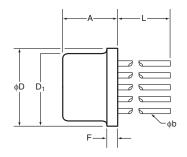
Printed Circuit Layout

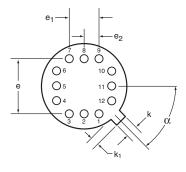
As with any high frequency device, a good PCB layout will enhance the performance of the KH206. Good ground plane construction and power supply bypassing close to the package are critical to achieving full performance. In the non-inverting configuration, the amplifier is sensitive to stray capacitance to ground at the inverting input. Hence, the inverting node connections should be small with minimal stray capacitance to the ground plane. Shunt capacitance across the feedback resistor should not be used to compensate for this effect.

Evaluation PC boards (part number 730008 for inverting, 730009 for non-inverting) for the KH206 are available.

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KH206 Package Dimensions





TO-8							
SYMBOL	INC	HES	MILIMETERS				
OTMBOL	Minimun	Maximum	Minimum	Maximum			
А	0.142	0.181	3.61	4.60			
фЬ	0.016	0.019	0.41	0.48			
φD	0.595	0.605	15.11	15.37			
φD ₁	0.543	0.555	13.79	14.10			
е	0.400) BSC	10.16 BSC				
e ₁	0.200) BSC	5.08 BSC				
e ₂	0.100) BSC	2.54 BSC				
F	0.016	0.030	0.41	0.76			
k	0.026	0.036	0.66	0.91			
k ₁	0.026	0.036	0.66	0.91			
L	0.310	0.340	7.87	8.64			
α	45°	BSC	45° BSC				

NOTES:

Seal: cap weld Lead finish: gold per MIL-M-38510 Package composition: Package: metal

Lid: Type A per MIL-M-38510

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